

Reliability and Test Condition

Item	Performance	Test Condition			
Electrical Performance Test					
Inductance	Refer to standard electrical	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.			
DCR	characteristics list.	CH16502,Agilent33420A Micro-Ohm Mete			
Operating Temperature	-55°C~+125°C (Including self - temperature	rise)			
Storage temperature and Humidity range	110~+40°C,50~60%RH (Product with tapin 255~+125°C (on board)	ng)			
Saturation Current (Isat)	Approximately △L30%	Saturation DC Current (Isat) will cause L0 to drop △L(%)			
Heat Rated Current (Irms)	Approximately $ riangle$ T40 $^{\circ}$ C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(^{\circ}C)$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer			
Reliability Test					
High Temperature Exposure(Storage) AEC-Q200		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature: 125±2°C Duration: 1000hrs Min. Measured at room temperature after placing for 24±2 hrs			
Temperature Cycling AEC-Q200	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value.	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: -55±2°C 30min Min. Step2: 125±2°C transition time 1min MAX. Step3: 125±2°C 30min Min. Step4: Low temp. transition time 1min MAX. Number of cycles: 1000 Measured at room temperature after placing for 24±2 hrs Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) 1.Baked at 50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2.Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3.Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs,keep at 25°C for 2hrs then keep at -10°C for 3hrs 4.Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.			
Moisture Resistance					
Biased Humidity (AEC-Q200)		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020DClassification Reflow Profiles) Humidity: 85±3% R.H, Temperature: 85℃±2℃ Duration: 1000hrs Min with 100% rated current. Measured at room temperature after placing for24±2hrs			



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High Temperature Operational Life (AEC-Q200)	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value.	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature: 125±2°C Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after placing for 24±2hrs					
External Visual	Appearance : No damage	Inspect device construction, marking and workmanship. Electrical Test not required.					
Physical Dimension	According to the product specification size measurement	According to the product specification size measurement					
Resistance to Solvents	Appearance:No damage.	Add aqueous wash chemical - OKEM clean or equivalent.					
Mechanical Shock	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the	Type SMD Lead	Peak value (g's) 100 100 s in each di	Norm duration (E	D) (ms)	Wave form Half-sine Half-sine	Velocity change (Vi)ft/sec 12.3 12.3
Vibration	specification value	IPC/JEDEC J-STD-020D Classification Reflow Profiles Oscillation Frequency: 10~2K~10Hz for 20 minute Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time: 12 hours (20 minutes, 12 cycles each of 3 orientations) • Test condition:					
Resistance to Soldering Heat	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value.	Tem	perature(°C) 260±5 older temp)	Time(s)	ramp/ and er	nperature /immersion nersion rate /s ±6 mm/s	e neat cycles
Thermal shock (AEC-Q200)	RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: -55±2℃ 15±1min Step2: 125±2℃ within 20Sec. Step3: 125±2℃ 15±1min Number of cycles: 300 Measured at room fempraturc after placing fo24±2hrs					

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ESD	Appearance : No damage.	10% Time (ns)
Solderability	More than 95% of the terminal electrode should be covered with solder •	Steam Aging: 16 hours ± 15 min Preheat: 150°C,60sec. Solder: Sn96.5% Ag3% Cu0. 5% Temperature: 245±5°C ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec. Depth: completely cover the termination
Electrical Characterization	Refer Specification for Approval	Summary to show Min, Max, Mean and Standard deviation
Flammability	Electrical Test not required	V-0 or V-1 are acceptable.
Board Flex	Appearance : No damage	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Place the 100mm X 40mm board into a fixture similar to the one shown in below Figure with the component facing down. The apparatus shall consist of mechanical means to apply a force which will bend the board (D) x = 2 mm minimum. The duration of the applied forces shall be 60 (+ 5) sec. The force is to be applied only once to the board. Support Solder Chip Printed circuit board before testing Printed circuit board under test Displacement



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Terminal Strength(SMD)	Appearance : No damage	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) With the component mounted on a PCB with the device to be tested, apply a 17.7 N (1.8 Kg) force to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.

Note: When there are questions concerning measurement result: measurement shall be made after

 48 ± 2 hours of recovery under the standard condition.

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Soldering	Mildly activated rosin fluxes are preferred. JANTEK terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.		
Lead Free Solder re- flow:	Recommended temperature profiles for re-flow soldering in Figure 1.		
Soldering Iron(Figure 2):	Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. Note: Preheat circuit and products to 150°C Never contact the ceramic with the iron tip Use a 20 watt soldering iron with tip diameter of 1.0mm 355°C tip temperature (max) 1.0mm tip diameter (max) Limit soldering time to 4~5 sec		



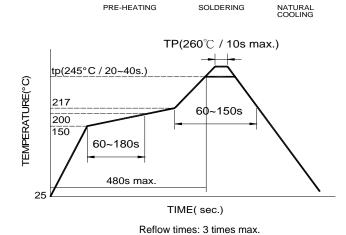


Fig.1

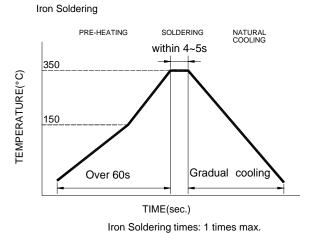


Fig.2